

Functional testing for cellular neural networks

Citation for published version (APA):

Willis, J., & Pineda de Gyvez, J. (1993). Functional testing for cellular neural networks. *Electronics Letters*, 29(25), 2206-2208. <https://doi.org/10.1049/el:19931482>

DOI:

[10.1049/el:19931482](https://doi.org/10.1049/el:19931482)

Document status and date:

Published: 01/01/1993

Document Version:

Publisher's PDF, also known as Version of Record (includes final page, issue and volume numbers)

Please check the document version of this publication:

- A submitted manuscript is the version of the article upon submission and before peer-review. There can be important differences between the submitted version and the official published version of record. People interested in the research are advised to contact the author for the final version of the publication, or visit the DOI to the publisher's website.
- The final author version and the galley proof are versions of the publication after peer review.
- The final published version features the final layout of the paper including the volume, issue and page numbers.

[Link to publication](#)

General rights

Copyright and moral rights for the publications made accessible in the public portal are retained by the authors and/or other copyright owners and it is a condition of accessing publications that users recognise and abide by the legal requirements associated with these rights.

- Users may download and print one copy of any publication from the public portal for the purpose of private study or research.
- You may not further distribute the material or use it for any profit-making activity or commercial gain
- You may freely distribute the URL identifying the publication in the public portal.

If the publication is distributed under the terms of Article 25fa of the Dutch Copyright Act, indicated by the "Taverne" license above, please follow below link for the End User Agreement:

www.tue.nl/taverne

Take down policy

If you believe that this document breaches copyright please contact us at:

openaccess@tue.nl

providing details and we will investigate your claim.

$$s_{11} = \frac{s_{11,b}s_{21,a} - s_{11,a}s_{21,b}s_{21,L}}{s_{21,a} - s_{21,b}s_{21,L}}$$

$$s_{22} = \frac{s_{11,a} - s_{11,b}}{s_{21,a} - s_{21,b}s_{21,L}}$$

can be calculated. $s_{21,L} = \exp(-j\beta l)$ is the forward transmission coefficient of the connecting line of length l and propagation coefficient β . Losses are neglected.

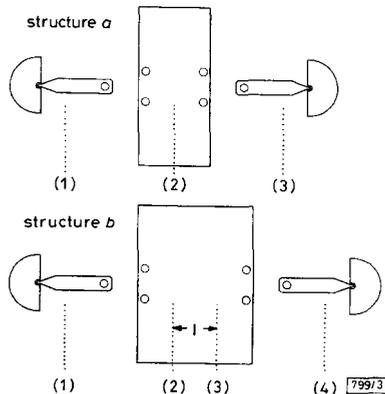


Fig. 3 Measurement structures consisting of two different double transitions

Results: The operating frequency of our radio module is 38GHz and the transition is matched to 50Ω . A substrate thickness of $170\mu\text{m}$ was chosen which needs a line width of $363\mu\text{m}$ for the microstrip and coplanar line. The slot width is $31\mu\text{m}$. The via holes are processed with a CO_2 laser and have diameters of $260\mu\text{m}$ on the top side and $180\text{--}230\mu\text{m}$ on the back side. These via holes have to be filled either in a soldering process or by means of an organic material (glop top filling).

The resulting excellent return loss of $\sim 20\text{dB}$ is shown in Fig. 4. Although we performed the measurement only from 36 to 40GHz we mention here that this structure can be used as a broadband transition because no frequency selective elements are incorporated.

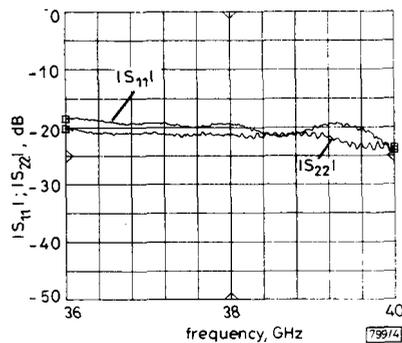


Fig. 4 Measured magnitude of reflection coefficients s_{11} and s_{22} of transition shown in Fig. 2

Conclusions: A novel microstrip-to-microstrip transition with side changed metallisation patterns has been experimentally demonstrated. A measurement procedure has been presented which extracts the transition properties by two different double transition measurements with electrical separation in the frequency domain. Although only measured around 38GHz the structure is suitable for a larger operating bandwidth.

Acknowledgments: The authors wish to express their thanks to Dr. Greving for helpful support and discussions and to Mr. Wagner for excellent technological realisation, both from Alcatel SEL AG, Stuttgart. This work is partially funded by the ministry of research

and development.

© IEE 1993

15 October 1993

Electronics Letters Online No: 19931439

U. Meier and H. Müller (Alcatel SEL AG, FS/ENNA, Lorenzstraße 10, D-70435 Stuttgart, Germany)

U. Meier is now with: Fachhochschule Lippe, Liebigstraße 87, D-32657 Lemgo, Germany

References

- 1 IZADIAN, J.S., and IZADIAN, S.M.: 'Microwave transition design' (Artech House, Inc., 1988)
- 2 WILLIAMS, D.F., and MIERS, T.H.: 'A coplanar probe to microstrip transition', *IEEE Trans.*, 1988, **MTT-36**, (7), pp. 1219-1223

Functional testing for cellular neural networks

J. Willis and J. Pineda de Gyvez

Indexing terms: Cellular neural networks, Testing

A novel approach to test the functional behaviour of cellular neural networks (CNNs) is proposed. The method attains 100% stuck-at fault coverage regardless of the array size without any extra hardware for its implementation. The Letter discusses the new fault model, presents the algorithmic procedures and shows simulated testing results.

Introduction: The testing of CNNs has been scarcely addressed [1]. The approach described in this Letter overcomes the testing constraints of [1] and achieves 100% fault detection without any extra hardware. Our testing method is based on the concept of C-testability [2]. Using this approach it is possible to determine the functionality of a processing array by applying a constant number of predetermined vectors independent of the array size and then comparing the actual output values to the predicted output values.

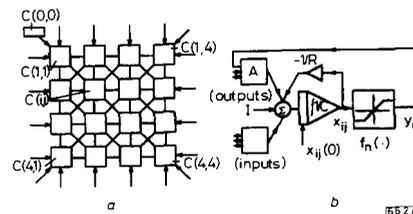


Fig. 1 Cellular neural network

a 4×4 processing array with border cell inputs shown
b Individual processing cell

A CNN is an analogue cellular nonlinear dynamic processor array (see Fig. 1a). The basic circuit unit is called the 'cell' [3,4] (see Fig. 1b). The first order nonlinear differential equation defining the dynamics of a cellular neural network can be written as follows:

$$C \frac{dx_{ij}(t)}{dt} = -\frac{1}{R} x_{ij}(t) + \sum_{C(k,l) \in N(i,j)} A(i,j;k,l) y_{kl}(t) + \sum_{C(k,l) \in N(i,j)} B(i,j;k,l) u_{kl} + I$$

$$y_{ij}(t) = \frac{1}{2} (|x_{ij}(t) + 1| - |x_{ij}(t) - 1|)$$

A and B are called 'templates' and are used to control the interaction between the cells $C(k,l)$ in the neighbourhood $N(i,j)$ of a reference cell $C(i,j)$. The variable $x(t)$ represents the state of the cell, u_{ij} represents the input image to the cell and y_{ij} represents the output equation.

A set of inputs is necessary to simulate interaction with

imaginary cells outside the processing array to ensure that the cells on the perimeter of the processing array achieve proper convergence. These imaginary cells are called border cells and form a ring around the processing array. The border cells are treated as members of the array for initialisation purposes and template implementation, but are not considered in the final state analysis.

Fault models: A CNN processor has only two output states. Commonly, in image processing applications these states appear as white or black pixels. A white pixel is associated to a cell whose output voltage is normalised to -1 V. A black pixel is associated to a cell whose normalised output voltage is $+1$ V. If a cell is unable to change from one state to the other, it is defined to be 'stuck-at-white' or 'stuck-at-black', depending on its current value. With the proposed test method it is possible to detect 100% of the stuck-at faults in the processor.

Test methods: The test procedure has two separate methods to detect faulty cells, a local method using the B template and a propagation method using the A template. The entire array can be tested using either of these methods regardless of its size. The advantage of the A template method is that it verifies that each cell is responding correctly to its neighbour's output.

The local method uses the input image and the B template to predict the final output state y_{ij} of each cell in the array. The algorithm for the local test procedure is shown below.

(i) let

$$A = \begin{bmatrix} 0 & 0 & 0 \\ 0 & 0 & 0 \\ 0 & 0 & 0 \end{bmatrix} \quad B = \begin{bmatrix} -1 & -1 & -1 \\ -1 & 1 & -1 \\ -1 & -1 & -1 \end{bmatrix} \quad I = 0$$

(ii) set the input image and border cells to white

$$\forall_{ij} u_{ij} = -1 \quad i = 0, 1, \dots, n+1 \quad j = 0, 1, \dots, m+1$$

(iii) set the initial conditions to white

$$\forall_{ij} x_{ij}(0) = -1 \quad i = 1, 2, \dots, n \quad j = 1, 2, \dots, m$$

(iv) allow the CNN to converge

(v) all cells, C_{ij} remaining at white are considered faulty, e.g. 'stuck-at-white' cells

$$\forall_{ij} y_{ij} \equiv -1 \rightarrow C_{ij} \text{ is faulty} \quad i = 1, 2, \dots, n \quad j = 1, 2, \dots, m$$

In step 2 the normalised value corresponding to a white input is -1 . Notice that the B template values are also -1 . The positive product of these two values results in current being injected into cell $C(i,j)$ from each of its eight neighbours. As the current is injected into the cell, the integrator voltage rises and the cell output reaches the normalised value of 1, which corresponds to black. If cell $C(i,j)$ fails to change under such overwhelming circumstances the conclusion that must be drawn is that the cell is 'stuck-at-white'. The same algorithm can be applied to find 'stuck-at-black' cells by changing all instances of white to black and -1 to 1 in steps 2–5 of the local test algorithm.

The test of the CNN array using the A template uses the idea of propagation of information across the network. The propagation ability of CNNs has been described before [5]. Here we use the same concept although the templates are different because we only want propagation and not 'full dragging' as described in [5]. In this case the input image does not matter and the border cells and initial conditions of the network are black. The A template causes each cell, $C(i,j)$, to look at the cell behind it, $C(i-1,j)$, and change to the colour of that cell. The algorithm for the propagation test is as follows:

(i) let

$$A = \begin{bmatrix} 0 & 0 & 0 \\ 5 & 2 & 0 \\ 0 & 0 & 0 \end{bmatrix} \quad B = \begin{bmatrix} 0 & 0 & 0 \\ 0 & 0 & 0 \\ 0 & 0 & 0 \end{bmatrix} \quad I = 0 \quad k = 1$$

(ii) set the border cells to black

$$\forall_{ij} u_{ij} = 1 \quad i = 0, 1, \dots, n+1 \quad j = 0, 1, \dots, m+1$$

$$\forall_{ij} u_{ij} = 1 \quad i = 0, 1, 2, \dots, n+1 \quad j = 0, m+1$$

(iii) set the initial conditions to black

$$\forall_{ij} x_{ij}(0) = 1 \quad i = 1, 2, \dots, n \quad j = 1, 2, \dots, m$$

(iv) allow the CNN to converge and save the results of rotation k

$$\forall_{ij} x_{ij}(t) \rightarrow C_{ij}^{(k)} \quad i = 1, 2, \dots, n \quad j = 1, 2, \dots, m$$

(v) add 1 to k and rotate A template clockwise 45°

(vi) if $k > 8$ continue to step 7, otherwise go to step 2

(vii) perform the logical OR of the results

$$\bigvee_{k=1}^{k=8} \forall_{ij} C_{ij}^{(k)} \rightarrow C_{ij} \quad i = 1, 2, \dots, n \quad j = 1, 2, \dots, m$$

(viii) all cells C_{ij} remaining at white are considered faulty, e.g. 'stuck-at-white' cells

$$\forall_{ij} y_{ij} \equiv -1 \rightarrow C_{ij} \text{ is faulty} \quad i = 1, 2, \dots, n \quad j = 1, 2, \dots, m$$

The process starts at the left edge of the array and propagates across the network to the right side. Because the border cells, $C(i,0)$, are black, the predicted result should be an all black image. If a 'stuck-at-white' fault is detected, then all properly functioning cells to the right of the stuck cell should also remain white. The faulty cell in effect casts its 'shadow' across the array. The situation where two or more faulty cells lie on the same row can be detected by rotating the A template clockwise 45° and repeating the test. The template should be rotated in this manner 360° to ensure complete coverage of the array. The 'stuck-at-white' cells can be determined by performing the logical OR of the resulting eight output images. The same procedure can be used to detect 'stuck-at-black' cells by changing all occurrences of white to black and -1 to 1 in steps 2–8 in the propagation test algorithm and performing a logical AND in step 7.

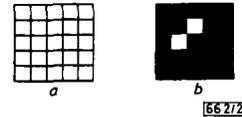


Fig. 2 Local test method

a Input image
b Final result

Simulated results: Using a CNN simulation program the above tests were applied to a 5×5 CNN network. In both the local and propagation tests, cells $C(3,2)$ and $C(2,3)$ were intentionally forced into the 'stuck-at-white' state. Fig. 2a shows the input image used for both tests. Fig. 2b shows the resulting final image after the simulation of the local test.

Fig. 3 shows the results of the simulation after the propagation test. Fig. 3a shows the 'shadow' effect discussed earlier. It is safe to assume by viewing Fig. 3a that cells $C(3,2)$ and $C(2,3)$ are faulty. Fig. 3b–h show the result after each rotation of the template by 45° and the new direction of propagation. The final results of the test are shown in Fig. 3i.

Conclusion: A testing method for CNNs has been presented which provides 100% fault detection with no additional hardware required. Any size array can be tested using a constant size set of input vectors. The local testing method provides 100% fault isolation. There are some fault location configurations that could impede fault isolation using the propagation test, i.e. if the faults form a complete rectangle, the status of the cells inside the rectangle would be unknown due to the shadow effect. This fact lowers the fault isolation capabilities of the propagation method but does

